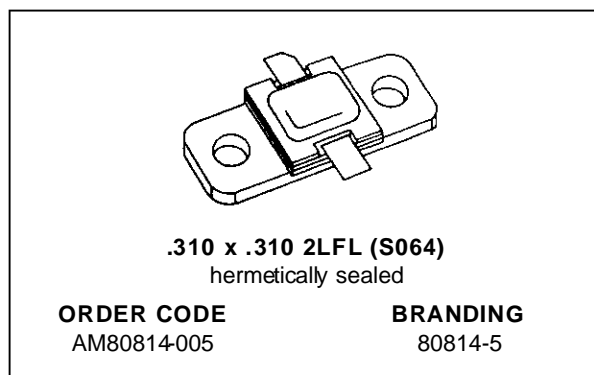


## RF & MICROWAVE TRANSISTORS L-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 5:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 5.0 W MIN. WITH 8.5 dB GAIN

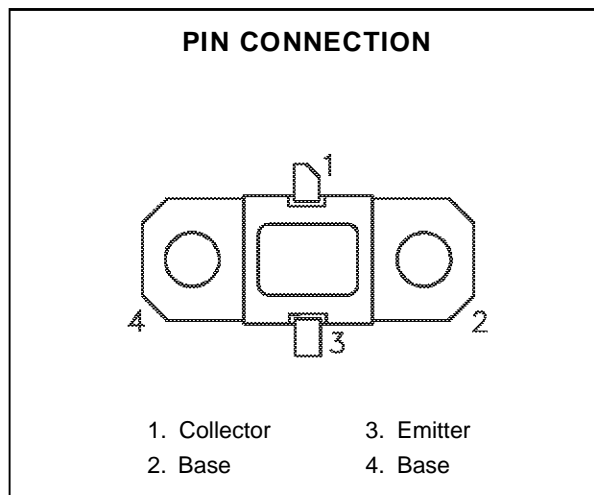


### DESCRIPTION

The AM80814-005 device is a high power Class C transistor specifically designed for L-Band radar pulsed driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 5:1 output VSWR at rated RF conditions. Low thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM80814-005 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.



### ABSOLUTE MAXIMUM RATINGS (T<sub>case</sub> = 25°C)

Symbol	Parameter	Value	Unit
P <sub>DISS</sub>	Power Dissipation* (T <sub>C</sub> ≤ 100°C)	23	W
I <sub>C</sub>	Device Current*	1.0	A
V <sub>CC</sub>	Collector-Supply Voltage*	28	V
T <sub>J</sub>	Junction Temperature (Pulsed RF Operation)	250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	6.5	°C/W
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\*Applies only to rated RF amplifier operation

**ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 1mA$	$I_E = 0mA$	48	—	—	V
$BV_{EBO}$	$I_E = 1mA$	$I_C = 0mA$	3.5	—	—	V
$BV_{CER}$	$I_C = 5mA$	$R_{BE} = 10\Omega$	48	—	—	V
$I_{CES}$	$V_{BE} = 0V$	$V_{CE} = 28V$	—	—	500	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = 250mA$	30	—	300	—

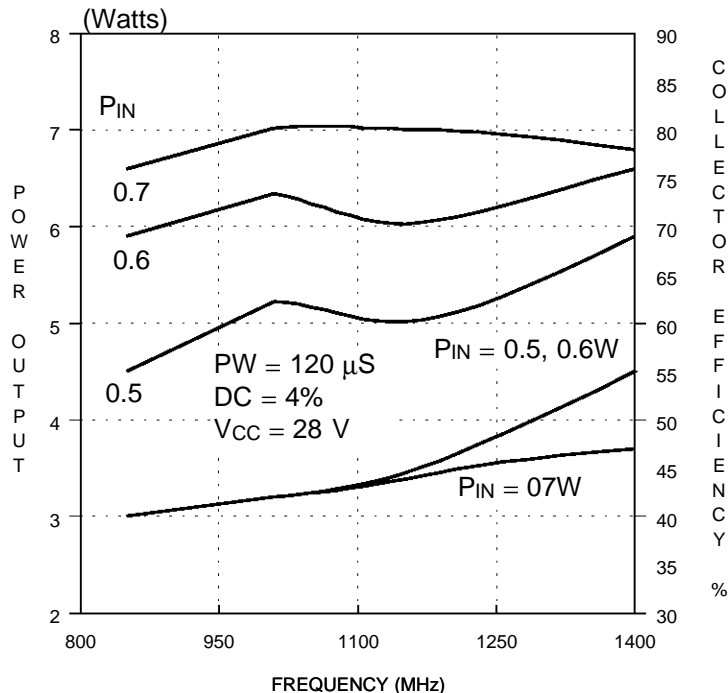
DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	5.0	5.7	—	W
$\eta_C$	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	35	40	—	%
$G_P$	$f = 850 - 1400MHz$	$P_{IN} = 0.7W$	$V_{CC} = 28V$	8.5	9.0	—	dB

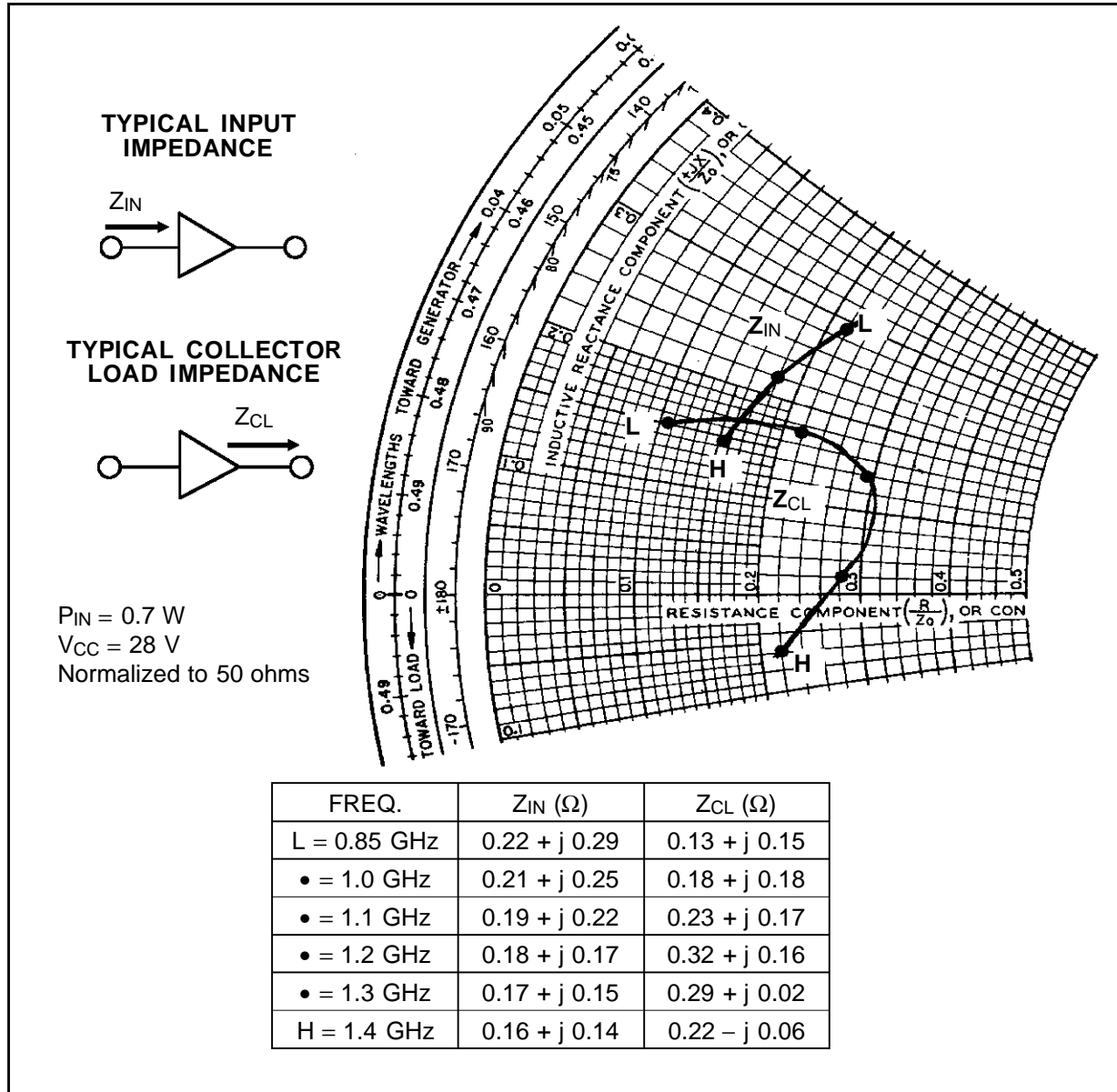
Note: Pulse Width = 120 $\mu$ S  
 Duty Cycle = 4%

**TYPICAL PERFORMANCE**

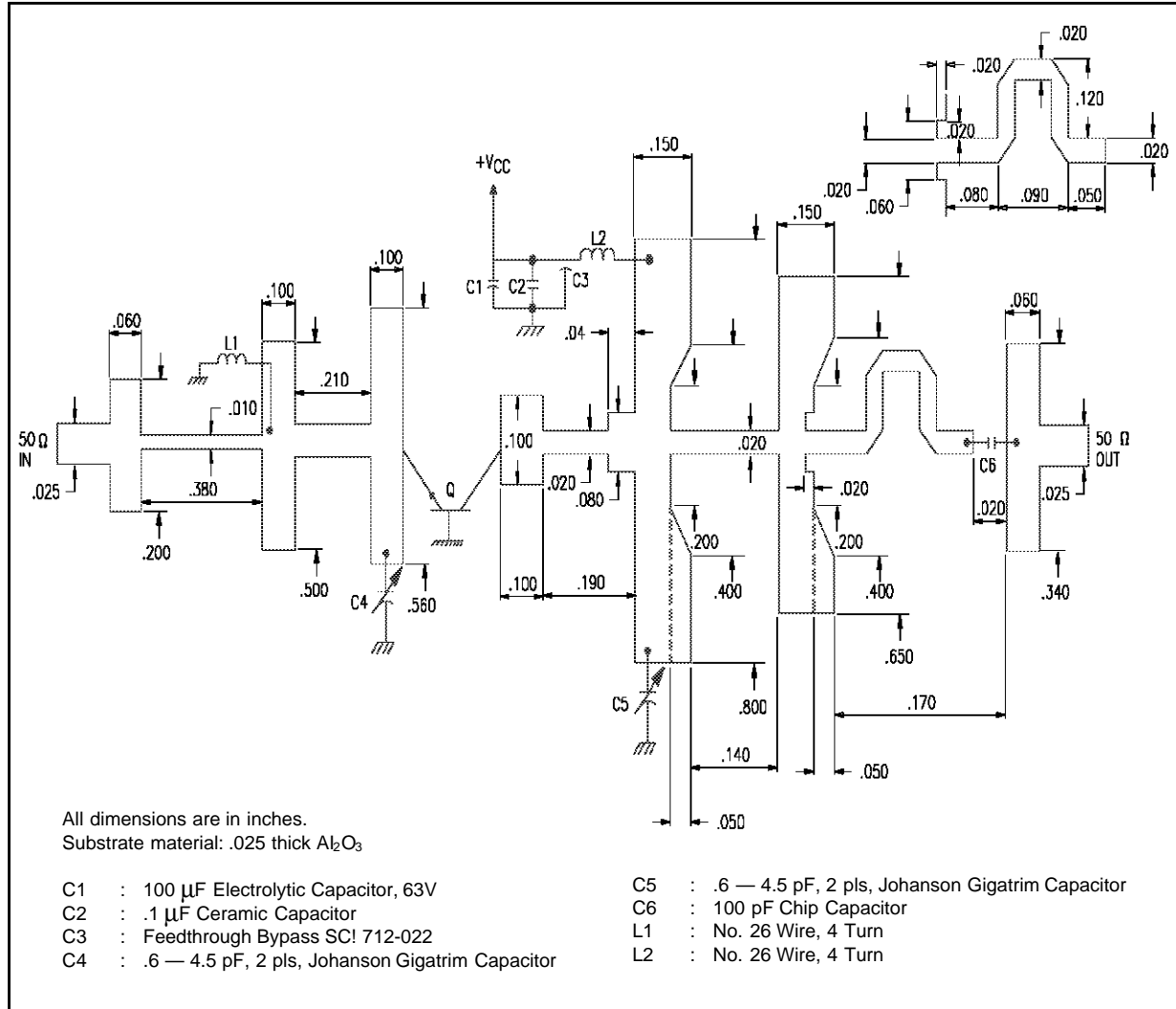
**POWER OUTPUT & COLLECTOR EFFICIENCY vs FREQUENCY**



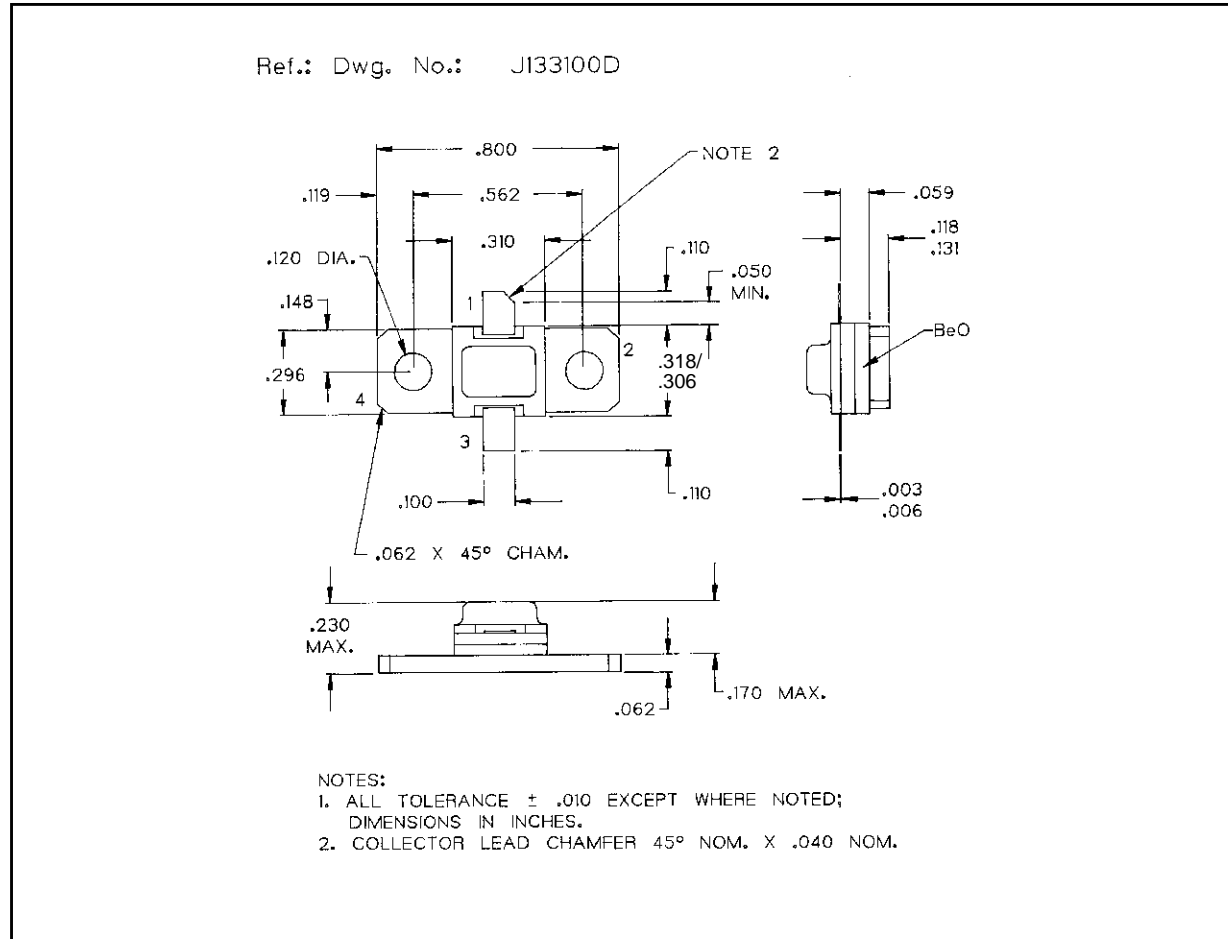
IMPEDANCE DATA



TEST CIRCUIT



## PACKAGE MECHANICAL DATA



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